



NIHON DEMPA KOGYO CO., LTD.

APPROVAL SHEET

DATE: April 12, 2005

CUSTOMER:

PRODUCT NAME: Saw Filter SMD

NDK Part Number

ISF-433.920000MHz

PREPARED BY: _____



CONFIRMED BY: _____



CUSTOMER APPROVAL:

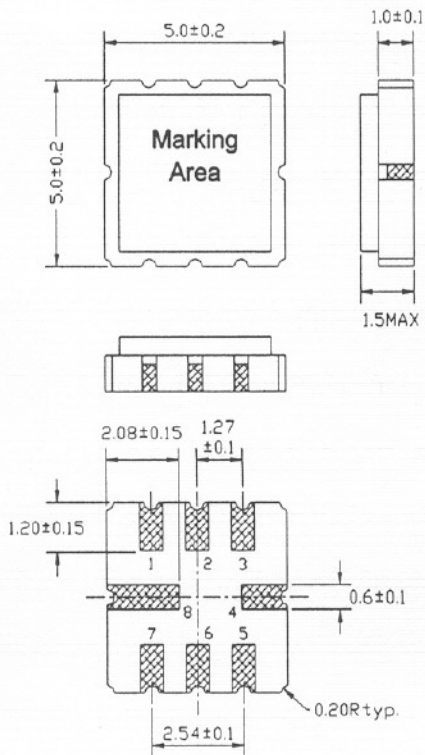
CHECKED BY: _____

APPROVED BY: _____



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1. Package Dimension





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2. Performance

2.1 Application

RF Low-loss SAW Filter for Wireless Remote Controller Receivers.

Center frequency(f_0): 433.92MHz

2.2 Maximum Rating

DC Voltage V_{DC} AC Voltage V_{pp}	10V 10V (50Hz / 60Hz)
Operation Temperature Range	-40°C to +85°C
Storage Temperature Range	-45°C to +85°C
Source Power	10dBm

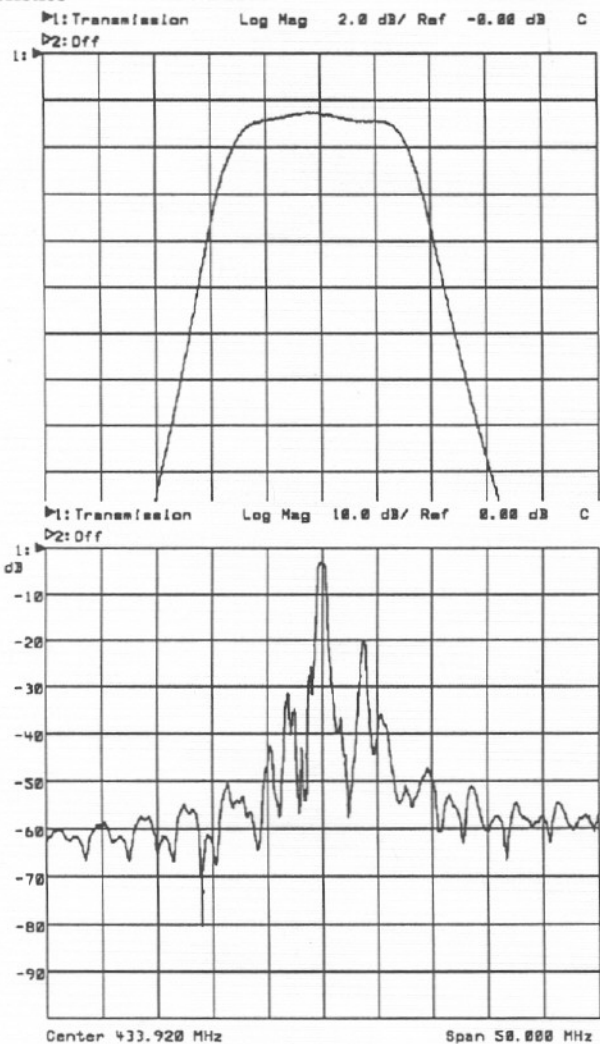
2.3 Electronic Characteristics

Item	Units	Minimum	Typical	Maximum
Center Frequency (f_0)	MHz	—	433.92	—
Insertion Loss 433.80MHz ~ 434.120MHz	dB	—	2.0	3.5
Pass Band 433.76MHz ~ 434.16MHz	dB	—	1.0	2.0
Relative Attenuation				
10.00MHz ~ 414.00MHz	dB	45.0	50.0	—
414.00MHz ~ 428.00MHz	dB	40.0	45.0	—
428.00MHz ~ 432.92MHz	dB	15.0	20.0	—
434.92MHz ~ 442.00MHz	dB	10.0	15.0	—
442.00MHz ~ 550.00MHz	dB	35.0	40.0	—
550.00MHz ~ 1000.00MHz	dB	45.0	50.0	—
Temperature Coefficient of Frequency	ppm/K ²	—	-0.03	—
External Impedance Match				
Series Inductance L	nH	—	33	—
Shunt Capacitance C	pF	—	5.6	—

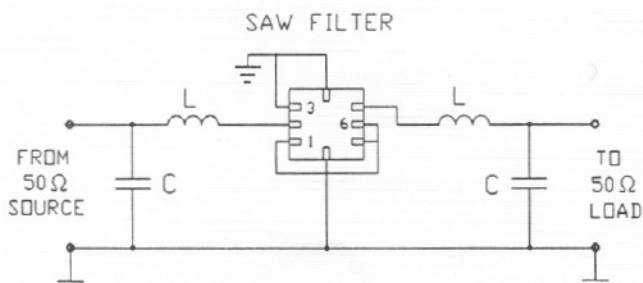


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2.4 Frequency Characteristics



2.5 Test Circuit





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3. Reliability

- 3.1 Mechanical Shock: The components shall remain within the electrical specifications after three one-half sine shock pulses(3000g's for 0.3ms) in each direction(for six total) along each of the three mutually perpendicular axes for a total of 18 shocks.
- 3.2 Vibration Fatigue: The components shall remain within the electrical specifications after loaded vibration at 20~55Hz, amplitude 1.5mm, X,Y,Z, direction, for 2 hours.
- 3.3 Leak Test
- 3.3.1 Gross Leak Test: Submerge samples into at +85°C water for at least 1 minute. Carefully observe the samples. No bubbles should be seen.
- 3.3.2 Fine Leak Test: Expose samples for testing to 60 PSIG Helium gas for 2 hours. Then transfer the same samples to another chamber and draw a vacuum. Measure the leak rate. Failure is defined if the leak rate exceeds 5×10^{-8} atm cc/sec Helium.
- 3.4 High Temperature Storage: The components shall remain within the electrical specifications after being kept at the 85°C \pm 2°C for 960 hours, then kept at room temperature for 2 hours.
- 3.5 Low Temperature Storage: The components shall remain within the electrical specifications after being kept at the -40°C \pm 2°C for 960 hours, then kept at room temperature for 2 hours.
- 3.6 Temperature Cycle: The components shall remain within the electrical specification after 32 cycles of high and low temperature testing (one cycle: 80°C for 30 minutes \rightarrow 25°C for 20 seconds \rightarrow -40°C for 30 minutes) than kept at room temperature for 2 hours.
- 3.7 Humidity Test: The components shall remain within the electrical specifications after being kept at the condition of ambient temperature 70°C, and 90~95% RH for 240 hours, then kept at room temperature and normal humidity for 4 hours.
- 3.8 Solder-heat Resistance: The components shall remain within the electrical specifications after dipped in the solder at 260°C \pm 5°C for 10 to 11 seconds, then kept at room temperature for 10 minutes.
- 3.9 Solderability: Solderability of terminal shall be kept at more than 80% after dipped in the solder flux at 230°C \pm 5°C for 5 \pm 1 seconds.
- 3.10 Storage: The components shall meet the electrical and mechanical specifications after 5 years storage, if stored within the temperature range of -40°C~+85°C and in the humidity of 20 to 60% r.h.

4. Remarks

4.1 Static voltage

Static voltage between signal load & ground may cause deterioration & destruction of the component. Please avoid static voltage.

4.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning.

4.3 Soldering

Only leads of component may be soldered. Please avoid soldering another part of component.



5. Packing

5.1 Dimensions

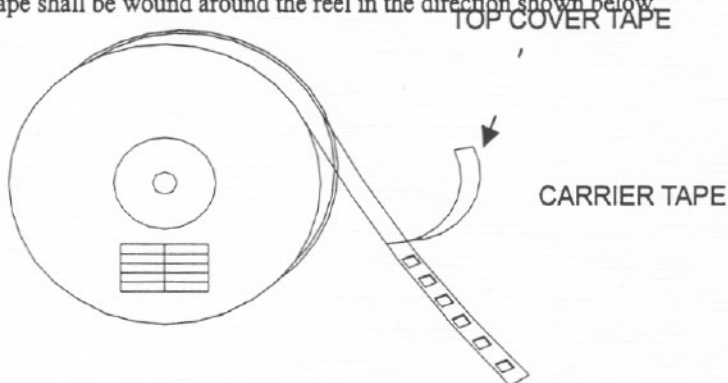
- (1) Carrier Tape: Figure 1
- (2) Reel: Figure 2
- (3) The product shall be packed properly not to be damaged during transportation and storage.

5.2 Reeling Quantity

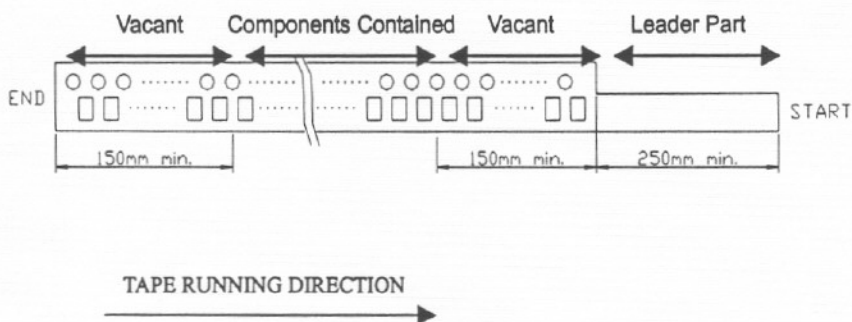
1,000 pcs/reel

5.3 Taping Structure

- (1) The tape shall be wound around the reel in the direction shown below.



- (2) Leader part and vacant position specifications.





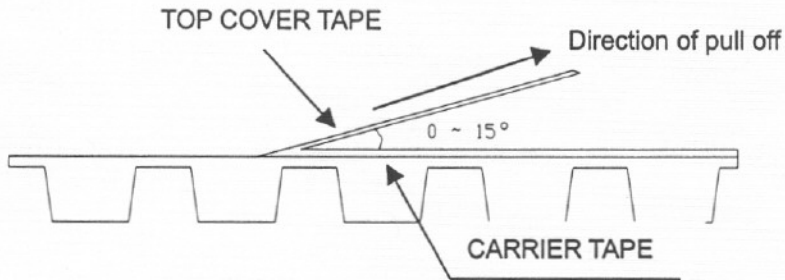
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6. Tape Specifications

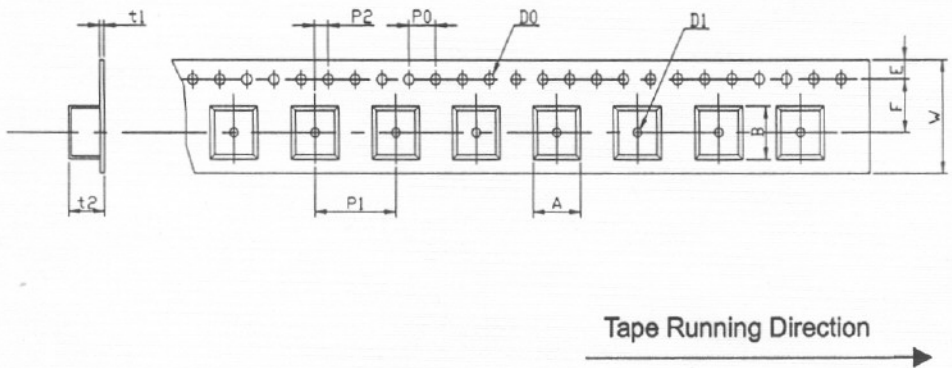
6.1 Tensile Strength of Carrier Tape: 4.4N/mm width

6.2 Top Cover Tape Adhesion (See the below figure)

- (1) pull off angle: 0~15°
- (2) speed: 300mm/min.
- (3) force: 20~70g



[F:



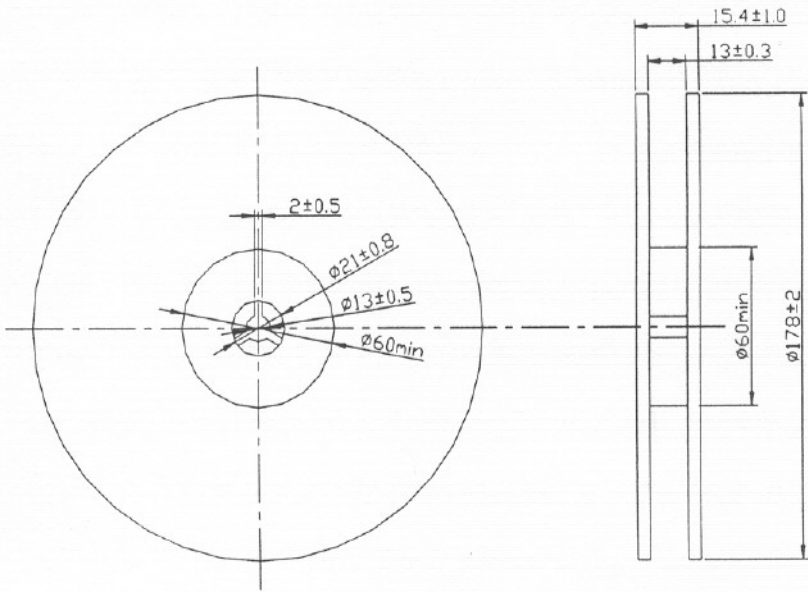
[Unit: mm]

12.0	5.5	1.75	4.0	8.0	2.2	Φ0.5	Φ1.5	0.11	1.25	5.5	5.5
±0.3	±0.1	±0.1	±0.2	±0.1	±0.2	±0.1	±0.25	max.	max.	max.	max.

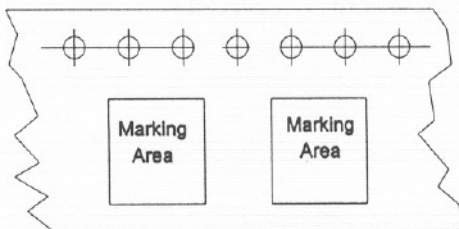


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[Figure 2] Reel Dimensions



[Figure 3] Part Direction



Tape Running Direction

Customer:

TEST DATA

Date : April 12, 2005

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Order No. : NDC-310413

Spec No. :

Type of Crystal Unit : ISF-433.920000MHz

Room Temp. :

Humidity :

Frequency in kHz, MHz, Hz	Lot No.	Passband Ripple				Insertion Loss							
		2.0dB				3.5dB							
1 433.920000	1	0.390				3.38							
2	2	0.520				3.39							
3	3	0.580				3.43							
4	4	0.420				3.40							
5	5	0.480				3.44							
6	6	0.510				3.45							
7	7	0.510				3.26							
8	8	0.520				3.31							
9	9	0.390				3.41							
10	10	0.480				3.42							
11													
12													
13													
14													
15													
Remarks													



Inspector:

MF

NIHON DEMPA KOGYO CO.,LTD.

QN 5453

NDK Spec NO.